SN54ABT574, SN74ABT574 OCTAL EDGE-TRIGGERED D-TYPE FLIP-FLOPS WITH 3-STATE OUTPUTS

D3705, JANUARY 1991 - REVISED JULY 1993

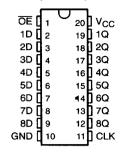
- State-of-the-Art EPIC-IIB™ BiCMOS Design Significantly Reduces Power Dissipation
- ESD Protection Exceeds 2000 V Per MIL-STD-883C, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Latch-Up Performance Exceeds 500 mA Per JEDEC Standard JESD-17
- Typical V_{OLP} (Output Ground Bounce)
 1 V at V_{CC} = 5 V, T_A = 25°C
- High-Drive Outputs (-32-mA I_{OH}, 64-mA I_{OL})
- Package Options Include Plastic Small-Outline (SOIC) and Shrink Small-Outline (SSOP) Packages, Ceramic Chip Carriers, and Plastic and Ceramic DIPs

description

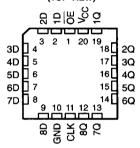
These 8-bit flip-flops feature 3-state outputs designed specifically for driving highly capacitive or relatively low-impedance loads. They are particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

The eight flip-flops of the 'ABT574 are edge-triggered D-type flip-flops. On the positive transition of the clock (CLK) input, the Q outputs are set to the logic levels that were set up at the data (D) inputs.

SN54ABT574...J PACKAGE SN74ABT574...DB, DW, OR N PACKAGE (TOP VIEW)



SN54ABT574 . . . FK PACKAGE (TOP VIEW)



A buffered output-enable (OE) input can be used to place the eight outputs in either a normal logic state (high or low logic levels) or a high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and increased drive provide the capability to drive bus lines without need for interface or pullup components.

The output-enable (\overline{OE}) input does not affect the internal operations of the flip-flops. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

To ensure the high-impedance state during power up or power down, \overline{OE} should be tied to V_{CC} through a pullupresistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

The SN74ABT574 is available in TI's shrink small-outline package (DB), which provides the same I/O pin count and functionality of standard small-outline packages in less than half the printed-circuit-board area.

The SN54ABT574 is characterized for operation over the full military temperature range of -55° C to 125°C. The SN74ABT574 is characterized for operation from -40° C to 85° C.

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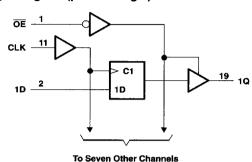
FUNCTION TABLE (each flip-flop)

	INPUTS	OUTPUT	
ŌĒ	CLK	D	Q
L	1	Н	Н
L	1	L	L
Ł	H or L	Х	Q_0
Н	X	X	z

logic symbol†

ŌΕ ΕN CLK > C1 1D 1D 10 18 2D 2Q 17 3D 3Q 16 4D **4Q** 6 15 5D 5Q 14 6D 6Q 13 7D 70 12 8D 8Q

logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage range	, v _{CC}		0.5 V to 7 V
Input voltage range, \	/ _I (see Note 1)		0.5 V to 7 V
Voltage range applied	d to any output in the high state	or power-off state, VO	0.5 V to 5.5 V
Current into any outp	ut in the low state, IO: SN54AB	T574	96 mA
	SN74AB	T574	128 mA
Input clamp current, I	$_{IK}$ $(V_I < 0)$		–18 mA
Output clamp current	, l _{OK} (V _O < 0)		50 mA
Maximum power diss	ipation at $T_A = 55^{\circ}C$ (in still air):	DB package	0.65 W
		DW package	0.85 W
		N package	1.3 W
Storage temperature	range		65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

NOTE 1: The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

OCTAL EDGE-TRIGGERED D-TYPE FLIP-FLOPS

WITH 3-STATE OUTPUTS D3705, JANUARY 1991 - REVISED JULY 1993

recommended operating conditions (see Note 2)

			SN54A	SN54ABT574		SN74ABT574	
			MIN	MAX	MIN	MAX	UNIT
VCC	Supply voltage		4.5	5.5	4.5	5.5	٧
VIH	High-level input voltage		2		2		٧
VIL	Low-level input voltage			0.8		8.0	٧
٧ı	Input voltage		0	Vcc	0	Vcc	٧
ЮН	High-level output current			-24		-32	mA
loL	Low-level output current			48		64	mA
Δt/Δν	Input transition rise or fall rate	Outputs enabled		5		5	ns/V
TA	Operating free-air temperature		-55	125	-40	85	°C

NOTE 2: Unused or floating inputs must be held high or low.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	TEST CONDITIONS			T _A = 25°C			SN54ABT574		SN74ABT574		UNIT
PARAMETER				MIN	TYP	MAX	MIN	MAX	MIN	MAX	וואט
VIK	V _{CC} = 4.5 V, I _I = -1	8 mA				-1.2		-1.2		-1.2	٧
	V _{CC} = 4.5 V, I _{OH} =	–3 mA		2.5			2.5		2.5		
.,	V _{CC} = 5 V, I _{OH} = -3 mA			3			3		3		v
VOH	V _{CC} = 4.5 V, I _{OH} =	-24 mA		2			2				٧
	V _{CC} = 4.5 V, l _{OH} =	-32 mA		2‡					2		
1/	V _{CC} = 4.5 V, I _{OL} = 48 mA					0.55		0.55			V
VOL	V _{CC} = 4.5 V, I _{OL} = 64 mA					0.55‡				0.55	·
l ₁	V _{CC} = 5.5 V, V _I = V	CC or GND				±1		±1		±1	μA
^I OZH	V _{CC} = 5.5 V, V _O =	2.7 V				50		10		50	μA
^I OZL	V _{CC} = 5.5 V, V _O =	0.5 V				-50		-10		-50	μA
loff	VCC = 0, Vi or V	/ _O ≤ 4.5 V				±100		±500		±100	μА
ICEX	V _{CC} = 5.5 V, V _O =	5.5 V	Outputs high			50		50		50	μА
1 _O §	V _{CC} = 5.5 V, V _O =	2.5 V		-50	-100	-180	-50	-180	-50	-180	mA
			Outputs high		1	250		250		250	μА
Icc	$V_{CC} = 5.5 \text{ V}, I_{O} = 0,$	0,	Outputs low		24	30		30		30	mA
	VI = VCC or GND		Outputs disabled		0.5	250		250		250	μΑ
ΔICC¶	V _{CC} = 5.5 V, One Other inputs at V _{CC} o		,			1.5		1.5		1.5	mA
Ci	V ₁ = 2.5 V or 0.5 V				3						pF
Co	V _O = 2.5 V or 0.5 V				8						рF

[†] All typical values are at $V_{CC} = 5 \text{ V}$.



[‡] On products compliant to MIL-STD-883, Class B, this parameter does not apply.

Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

This is the increase in supply current for each input that is at the specified TTL voltage level rather than VCC or GND.

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timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

			V _{CC} = 5 V, T _A = 25°C				SN74ABT574		UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	1
fclock	Clock frequency			150		150		150	MHz
t _w	Pulse duration, CLK high or low		3.3		3.3		33		ns
		High	1		1.5		1		
t _{SU} Setup time, data before CLK↑	Setup time, data before CLK	Low	1.5		2		1.5		ns+
th	Hold time, data after CLK↑	High or low	15		2	-	1.5†		ns

[†] This data sheet limit may vary among suppliers

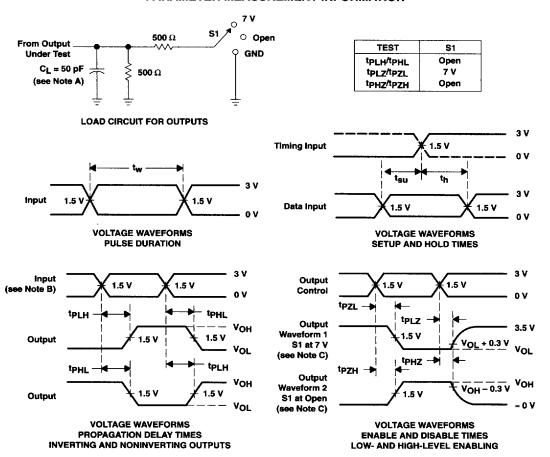
switching characteristics over recommended ranges of supply voltage and operating free-air temperature, C_L = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _C	V _{CC} = 5 V, T _A = 25°C			SN54ABT574		SN74ABT574	
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	l
f _{max}			150	200		150		150		MHz
[†] PLH	CLK	Q	2.2	39	6.2	2.2	7	2.2	6.8	
^t PHL			3	4 8	66	3	7.4	3	7 1	ns
^t PZH	ŌĒ	Q	1	3.3	43	1	6	1	5 1	
^t PZL		ď	2.5	4.7	59	25	6.8	2.5	67	ns
t _{PHZ}	ŌĖ	Q	2.4	49	62	2.4	73	2.4	7	
^t PLZ		J 4	2	4	5.8	2	6.9	2	6.5	ns



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PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_O = 50~\Omega$, $t_f \leq$ 2.5 ns, $t_f \leq$ 2.5 ns.
- C. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

